



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BVsss	Rss(on) Typ	Is Max T _A = +25°C
12V	$4.7 \text{m}\Omega$ @ V _{GS} = 3.3V	8.8A

Description

This new generation MOSFET is designed to minimize the on-state resistance (Rss(on)) yet maintain superior switching performance, making it ideal for high-efficiency power-management applications.

Applications

- Battery management
- Load switches
- Battery protections

Features

- CSP with Footprint 1.79mm x 1.47mm
- Height = 0.10mm (Typical) for Low Profile
- ESD Protection of Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/104/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

 https://www.diodes.com/quality/product-definitions/

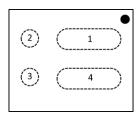
Mechanical Data

- Package: X4-DSN1815-4
- Terminal Connections: See Diagram Below
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiAu. Solderable per MIL-STD-202, Method 208 @4
- Weight: 0.0026 grams (Approximate)



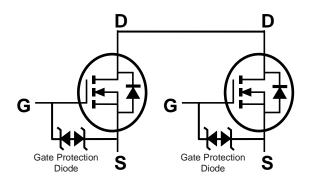
ESD PROTECTED





Source 1: 1 Gate 1: 2 Source 2: 4 Gate 2: 3

Top View



Equivalent Circuit

Ordering Information (Note 4)

Part Number	Paskage	Packing		
Fait Number	Package	Qty.	Carrier	
DMN15M5UCA4-7	X4-DSN1815-4	3000	Tape & Reel	

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.



Marking Information

ΥW

P5 = Product Type Marking Code YW = Date Code Marking Y or \overline{Y} = Year (ex: 4 = 2024) W or \overline{W} = Week (ex: a = Week 27; z Represents Week 52 and 53)

Date Code Key

Year	2024	2025	2026	2027	2028	2029	2030	2031	2032	2033	2034	2035
Code	4	5	6	7	8	9	0	1	2	3	4	5
Week	Week 1-26			27-52			53					
Code		A	-Z			а	-z			7	Z	

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Source-Source Voltage			Vsss	12	V
Gate-Source Voltage	V _{GSS}	±8	V		
Continuous Courses Coursest (Note 5) V 45V	Steady State	T _A = +25°C	Is	9.8	А
Continuous Source Current (Note 5) V _{GS} = 4.5V		T _A = +70°C		7.8	
Continuous Courses Coursest (Note 5) V 95V	Steady State	T _A = +25°C		8.7	А
Continuous Source Current (Note 5) V _{GS} = 2.5V	Steady State	T _A = +70°C	Is	6.9	
Pulsed Source Current (Note 6)	Isм	82	Α		

ESD Ratings (Note 7)

Characteristic	Symbol	Value	Unit	JEDEC Class
Electrostatic Discharge - Human Body Model	ESD HBM	4000	V	2
Electrostatic Discharge - Machine Model	ESD MM	200	V	_

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	PD	1.8	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5)	Reja	70	°C/W
Power Dissipation (Note 8)	PD	0.7	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 8)	R _{θJA}	179	°C/W
Operating and Storage Temperature Range	TJ, TSTG	-55 to +150	°C

Notes: 5. Device mounted on FR-4 material with 1inch 2 (6.45cm 2), 2oz. (0.071mm thick) Cu.

- 6. Repetitive rating, pulse width limited by junction temperature.
- 7. Based on characterization data only. Not subject to production testing.
- 8. Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.



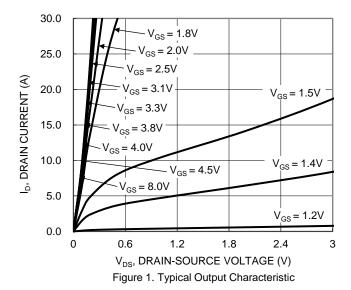
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 9)							
Source -Source Breakdown Voltage	BVsss	12	_	_	V	$V_{GS} = 0V$, $I_{S} = 1mA$	
Zero Gate Voltage Drain Current T _J = +25°C	Isss	_	_	1	μA	Vss = 10V, Vgs = 0V	
Gate-Source Leakage	loos	_	_	±5	μA	$V_{GS} = \pm 8V$, $V_{SS} = 0V$	
Gale-Source Leakage	Igss	_	0.2	±1	μA	$V_{GS} = \pm 5V$, $V_{SS} = 0V$	
ON CHARACTERISTICS (Note 9)							
Gate Threshold Voltage	V _{GS(TH)}	0.35	_	1.4	V	$V_{SS} = 10V$, $Is = 0.87mA$	
Static Source-Source On-Resistance	Rss(ON)	2.5	4.7	6	mΩ	$V_{GS} = 3.3V$, $I_{S} = 4A$	
Diode Forward Voltage	Vss		0.7	1.2	V	$V_{GS} = 0V$, $I_{S} = 4A$	
DYNAMIC CHARACTERISTICS (Note 10)							
Input Capacitance	C _{iss}	_	1669	_		V _{SS} = 6V, V _{GS} = 0V f = 1.0MHz	
Output Capacitance	Coss	_	393	_	pF		
Reverse Transfer Capacitance	Crss		265	_			
Gate Resistance	Rg		365	_	Ω	$V_{GS} = 0V$, $V_{DS} = 0V$, $f = 1MHz$	
Total Gate Charge	Qg	_	21.7	_			
Gate-Source Charge	Qgs	_	5.7	_	nC	$V_{DD} = 6V$, $V_{GS} = 4V$	
Gate-Drain Charge	Q_{gd}		3.2	_	110	Is = 6.8A	
Gate Charge at V _{TH}	$Q_{g(TH)}$		4.4	_			
Turn-On Delay Time	td(ON)	_	178	_			
Turn-On Rise Time	t _R	_	792	_		$V_{DD} = 6V$, $V_{GS} = 4V$	
Turn-Off Delay Time	tD(OFF)	_	2221	_	ns	Is = 6.8A	
Turn-Off Fall Time	t _F	_	1713	_			

Notes:

^{9.} Short duration pulse test used to minimize self-heating effect. 10. Guaranteed by design. Not subject to production testing.





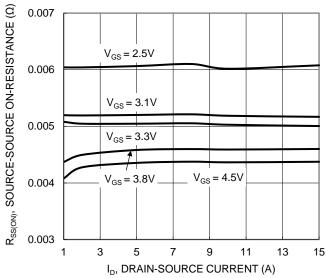


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

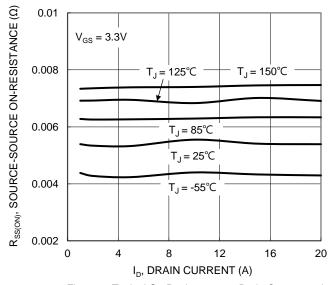
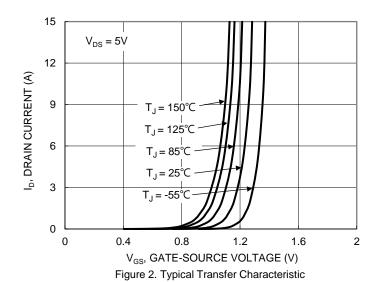
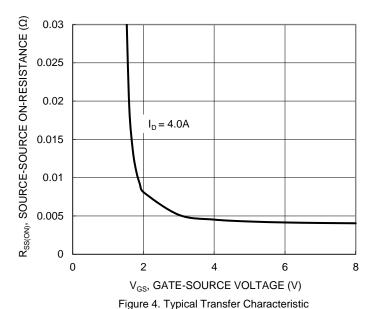


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature





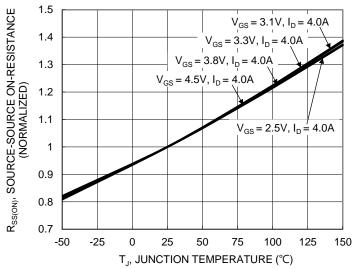


Figure 6. On-Resistance Variation with Junction Temperature





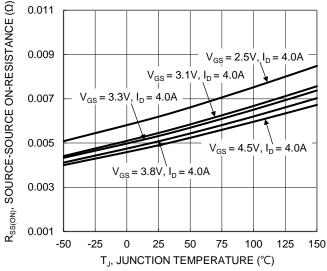


Figure 7. On-Resistance Variation with Junction Temperature

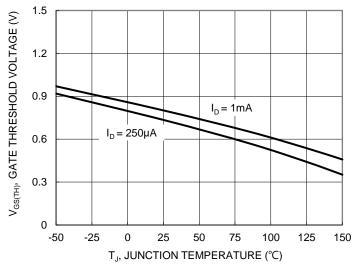


Figure 8. Gate Threshold Variation vs. Junction Temperature

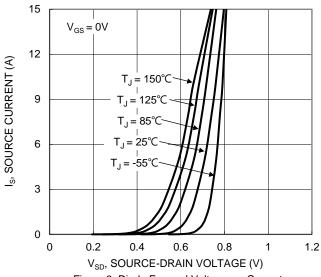
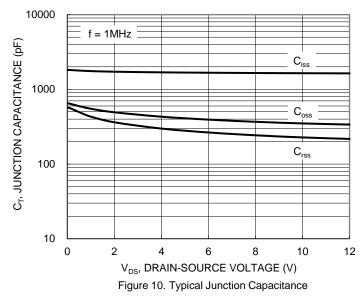
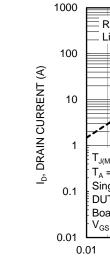


Figure 9. Diode Forward Voltage vs. Current

 $V_{DD} = 6V, I_{S} = 6.8A$



54



R_{SS(ON)} Limited $T_{J(Max)} = 150^{\circ}C$ $T_A = 25^{\circ}C$ Single Pulse DUT on 1*MRP Board $V_{GS} = 4.5V$ 0.1 10 100 V_{DS}, DRAIN-SOURCE VOLTAGE (V)

 Q_g (nC) Figure 11. Gate Charge

27

18

36

45

9

10

8

6

4

2

0

0

 $V_{GS}(V)$



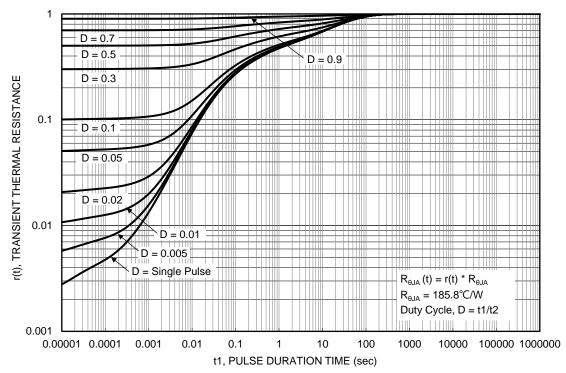


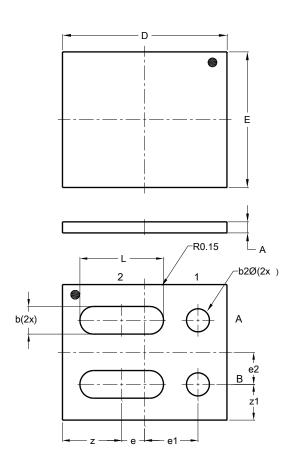
Figure 13. Transient Thermal Resistance

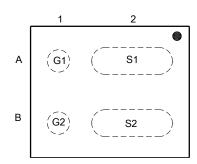


Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X4-DSN1815-4





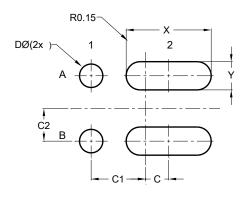
Pin Assignment					
A2	A2 S1				
B1	G1				
C2	S1				
D2 S2					
E1 G2					
F2 S2					

	X4-DSN1815-4						
Dim	Min	Max	Тур				
Α	0.05	0.15	0.10				
b	0.27	0.33	0.30				
b2	0.22	0.28	0.25				
D	1.76	1.82	1.79				
Е	1.44	1.50	1.47				
е	-		0.25				
e1	-		0.58				
e2	-		0.3475				
L	0.88	0.94	0.91				
Z	-		0.645				
z 1			0.3875				
Al	All Dimensions in mm						

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

X4-DSN1815-4



Dimensions	Value (in mm)
С	0.250
C1	0.580
C2	0.3475
D	0.250
Х	0.910
Υ	0.300



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